

Notice of References Cited	Application/Control No. 10/763,010	Applicant(s)/Patent Under Reexamination BREITSCHWERDT ET AL.	
	Examiner Binh X. Tran	Art Unit 1765	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,506,687	01-2003	Izawa et al.	438/729
*	B	US-6,333,269	12-2001	Naito et al.	438/706
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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